SEMIX 353GB126HD



Trench IGBT Modules

Features

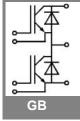
- Homogeneous Si
- Trench = Trenchgate technology
- V_{CE(sat)} with positive temperature coefficient
- High short circuit capability

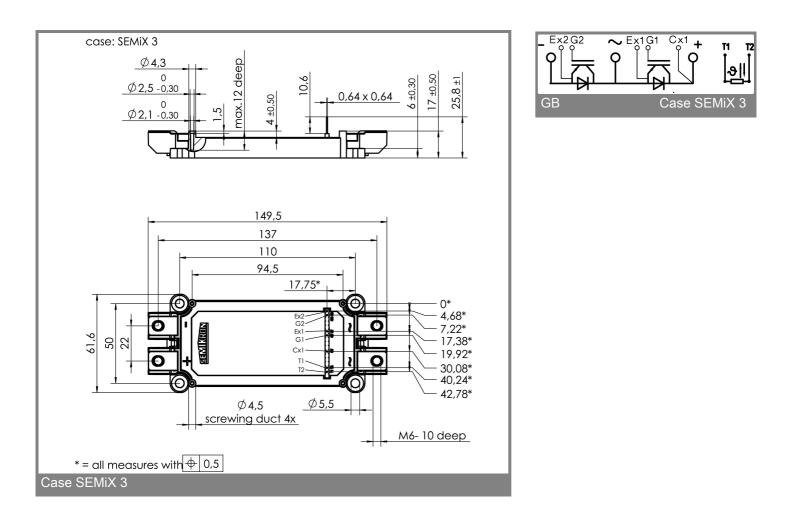
Typical Applications

- AC inverter drives
- UPS
- Electronic welders

Absolute	Maximum Ratings	$T_c = 25^{\circ}C$, unless otherwise	$T_c = 25^{\circ}C$, unless otherwise specified						
Symbol	Conditions	Values	Units						
IGBT									
V _{CES}		1200	V						
I _C	T _c = 25 (80) °C	380 (280)	А						
I _{CRM}	T _c = 25 (80) °C, t _p = 1 ms	760 (560)	А						
V _{GES}	r P	± 20	V						
T _{vj} , (T _{stg})	$T_{OPERATION} \leq T_{stg}$	- 40 + 150 (125)	°C						
V _{isol}	AC, 1 min.	4000	V						
Inverse diode									
I _F = - I _C	T _c = 25 (125) °C	270 (190)	А						
I _{FRM}	T _c = 25 (125) °C, t _p = 1 ms	760 (560)	А						
I _{FSM}	t _p = 10 ms; sin.; T _j = 25 °C		А						

Characteristics		$T_c = 25^{\circ}C$, unless otherwise specified				
Symbol	Conditions	min.	typ.	max.	Units	
IGBT						
ICES	$V_{GE} = V_{CE}, I_{C} = 9 \text{ mA}$ $V_{GE} = 0, V_{CE} = V_{CES}, T_{j} = 25 (125) ^{\circ}C$	5	5,8	6,5 1,5	V mA	
02(10)	$\Gamma_{j} = 25 (125) ^{\circ}C$		1 (0,9)	1,2 (1,1)	V	
-	V _{GE} = 15 V, T _j = 25 (125) °C		0,3 (4,9)		mΩ	
	_C = 225 A, V _{GE} = 15 V, T _j = 25 (125) °C, chip level		1,7 (2)	2,1 (2,4)	V	
103	under following conditions		16		nF	
	V _{GE} = 0, V _{CE} = 25 V, f = 1 MHz		0,9		nF	
C _{res}			0,7		nF	
L _{CE}			20		nH	
00.55	resistance, terminal-chip, T _c = 25 (125) °C		0,8 (1,2)		mΩ	
	V _{CC} = 600 V, I _C = 225 A				ns	
t _{d(off)} /t _f	V _{GE} = ± 15 V				ns	
E _{on} (E _{off})	$R_{Gon} = R_{Goff} = 4 \Omega, T_j = 125 \text{°C}$		30 (35)		mJ	
Inverse dio	de					
	_F = 225 A; V _{GE} = 0 V; T _j = 25 (125) °C, chip level		1,6 (1,6)	1,8 (1,8)	V	
	Γ _j = 25 (125) °C		1 (0,8)	1,1 (0,9)	V	
r _T	T _j = 25 (125) °C		2,7 (3,6)	3,1 (4)	mΩ	
	_F = 225 A; T _j = 25 (125) °C				A	
	di/dt = A/µs				μC	
	V _{GE} = 0 V				mJ	
	aracteristics					
ung-c)	per IGBT			0,095	K/W	
ung-c)D	per Inverse Diode			0,225	K/W	
(i)(j=c)i D	per FWD				K/W	
R _{th(c-s)}	per module		0,04		K/W	
Temperatu						
R ₂₅	T _c = 25 °C		5 ±5%		kΩ	
B _{25/85} I	R ₂ =R ₁ exp[B(1/T ₂ -1/T ₁)] ; T[K];B		3420		к	
Mechanica	I data				·	
	to heatsink (M5) / for terminals (M6)	3/2,5		5 /5	Nm	
w			289		g	





This is an electrostatic discharge sensitive device (ESDS), international standard IEC 60747-1, Chapter IX.

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